

Search Notes

Application/Control No.

09/473,619

Examiner

Christopher H. Yaen

Applicant(s)/Patent under
Reexamination

SIMAN ET AL.

Art Unit

1643

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Stic seq search SEQ ID No: 1 and 2	1/3/2006	CHY
west-and palm inventor search	1/3/2005	CHY
west- enclosed	1/3/2005	CHY
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